Page 1 of \$ APPLICATION NO : ATTY. DOCKET NO.: 10/661,397 88265-7228 APPLICANT: LIST OF REFERENCES OF BY APPLICANT Zheng et al. (Use several sheets if necessary) FILING DATE: GROUP: 1761 September 11, 2003 **U.S. PATENT DOCUMENTS** FILING DATE IF APPROPRIATE EXAMINER INITIAL CLASS SUBCLASS DOCUMENT NUMBER DATE. 009/14 07/1999 A23C an 5,922,380 Takihara 1/00 A23G MW 03/1999 Hansen et al. AB 5,888,562 188.28 11/1994 Zenner et al. AC 5,364,555 01/1990 Kotaki et al. 426 118 4,897,273 AD 597 4,539,216 09/1985 426 AE 1/234 4,378,380 03/1983 Scarpellino et al. A23L AF 09/1981 215 **228** AG 4,287,995 Moriya 71 99 3,540,889 11/1970 Clinton et al. 12/1969 426 460 Pitchon et al. 3,482,987 FOREIGN PATENT DOCUMENTS SUBCLASS TRANSLATION DOCUMENT NUMBER DATE COUNTRY YES NO EP 0861596 09/1998 **EUROPE** Х X **EUROPE** EP0328336 08/1989 07/1995 **PCT** X WO9518540 X 04/1996 **PCT** ΑM WO9611861 WO 03 101216 12/2003 **PCT** AN X 08/1996 AO 08196212 English Abstract Japan Х 62278948 English Abstract 12/1987 Japan X 08-182486 English Abstract 12/1987 Japan Х 07/1950 Great Britain 640241 44914 English Abstract Hungary OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.) Holscher, W. et al, XP008007644, "Investigations of Roasted Coffee Freshness With An Improved Headspace Technique-Aromafrische Mittles Einer Vergesserten Headspace-Methodik", Forschung, vol. 195, no. 1, 1992, pages 33-38 Semmelroch, P. et al., XP000602989 "Analysis of Roasted Coffce Powders And Brews By Gas Chromatography-

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